

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/537,490	FUKUDA, KUNIO	
Examiner Tuan H. Nguyen	Art Unit 2618	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0001758	05-2001	Greeff et al.	455/41
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	10-145103	05-1998	Japan	Tanaka Hiroaki et al.	H01P 1/18
	O	2001-024549	01-2001	Japan	Fujita Taku et al.	H04B 1/59
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.